

Laboratory S.V. Precision Instruments, Shed No. 11A & 11B, Type-III, Industrial Estate, Kukatpally, Hyderabad, Telangana
Accreditation Standard ISO/IEC 17025: 2005
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Sl.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (\pm)	Remarks
<u>MECHANICAL CALIBRATION</u>				
1.	DIMENSION (BASIC MEASURING INSTRUMENT, GAUGE ETC.)			
1.	Slip Gauges ^s	0.5 mm to 20 mm 20 mm to 50 mm 50 mm to 70 mm 70 mm to 100 mm	0.12 μ m 0.15 μ m 0.20 μ m 0.35 μ m	Using Slip Gauge Calibration Tester & Gauge Block by Comparison Method IS – 2984 – 2003, ISO 3650 – 1998
2.	Setting Rods ^s	25 mm to 300 mm 300 mm to 600 mm 600 mm to 1000 mm	2.2 μ m 3.5 μ m 5.3 μ m	Using Slip Gauges , Length Bars & Electronic Comparator
3.	Plain Plug Gauges ^s	5 mm to 125 mm	2.4 μ m	Using Slip Gauges & Comparator Stand by Comparison Method IS – 6137 – 1983 IS – 6244 – 1980 IS – 6246 – 1980
4.	Vee Blocks ^s Parallelism & Symmetricity	25 mm to 150 mm	5.0 μ m	Using Height Gauge, Digimatic Gauge & Mandrel by Comparison Method IS – 4960 – 1968 IS – 2949 – 1992
	Squareness	25 mm to 150 mm	8.0 μ m	
5.	Feeler Gauge Sets ^s	0.5 mm to 1 mm	3.0 μ m	Using External Micrometer by Comparison Method IS – 3179 – 1990
6.	Caliper Checkers ^s	0 to 600 mm	8.5 μ m	Using Length Bars & Linear Height Gauge

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7.	Coating Thickness Foils ^s	0.01 mm to 3 mm	2.0 μ m	Using Electronic Comparator
8.	Calipers ^s L.C.: 0.02 mm (All Types)	0 to 150 mm 0 to 450 mm 0 to 600 mm 0 to 1000 mm	12.0 μ m 17.0 μ m 17.0 μ m 18.0 μ m	Using Slip Gauges & Length Bars by Comparison Method IS – 3651 – 1985
	L.C.: 0.01 mm	0 to 300 mm 0 to 600 mm	10.0 μ m 14.0 μ m	
9.	Height Gauges ^s L.C.: 0.02 mm (Vernier, Dial Digital)	0 to 1000 mm	18.0 μ m	Using Slip Gauges, Length Bars & Digimatic Dial Gauge by Comparison Method IS – 2921 – 1988 IS – 2921 – 2016
	L.C.: 0.01 mm	0 to 300 mm 0 to 600 mm	7.0 μ m 7.9 μ m	
10.	Depth Verniers ^s L.C.: 0.02 mm	0 to 300 mm	15.0 μ m	Using Slip Gauges & Length Bars by Comparison Method IS – 4213 – 1991
11.	External Micrometers ^s L.C.: 0.01 mm	0 to 100 mm 100 mm to 300 mm 300 mm to 600 mm 600 mm to 1000 mm	3.3 μ m 9.0 μ m 12.0 μ m 16.0 μ m	Using Slip Gauges & Length Bars by Comparison Method IS– 2967 – 1983
	L.C.: 0.001 mm	0 to 300 mm	1.7 μ m	
12.	Dial Type Inside Calipers ^s L.C.: 0.01 mm	10 mm to 55 mm	7.0 μ m	Using Slip Gauges
13.	Depth Micrometers ^s L.C.: 0.01 mm	0 to 100 mm	4.0 μ m	Using Slip Gauges & Length Bars
		0 to 300 mm	7.0 μ m	

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14.	Height Masters [§] L.C.: 0.002 mm	0 to 300 mm	3.0 μ m	Using Slip gauges & Electronic Comparator by Comparison Method IS-13907-1994
15.	Dial Calibration Testers [§] L.C.: 1 μ m	0 to 25 mm	1.9 μ m	Using Slip gauges & Electronic Comparator
16.	Dial Thickness Gauges (Digimatic) [§] L.C.: 0.01 mm	0 to 25 mm	2.9 μ m	Using Slip Gauges
		L.C.: 0.001 mm 0 to 12 mm	0.9 μ m	
17.	Lever Type Dial Gauge [§] L.C.: 0.001 mm	0 to 1 mm	1.9 μ m	Using Dial Gauge Testing Stand With Electronic Probe Comparison Method IS- 1498-1985
18.	Plunger Type Dials [§] L.C.: 0.001 mm	0 to 25 mm	1.9 μ m	Using Dial Gauge Testing Stand With Electronic Comparator Comparison Method IS - 2092 - 1983
	Plunger Type Dials L.C.: 0.01 mm	0 to 50 mm	2.9 μ m	Using Length Measuring Machine
19.	Bore Dial Gauges [§]	Upto 2 mm Travel	5.0 μ m	Using Digimatic Gauge & Dial Calibration Tester Comparison Method JIS - B - 7515

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20.	Steel Scales [§]	100 mm to 2000 mm	$311 \sqrt{\frac{L}{1000}}$ 'L' is in mm	Using Tape Scale Calibrator by Comparison Method IS - 1481 - 1970
21.	Steel Tapes [§]	0 to 30 Meters	$311 \sqrt{\frac{L}{1000}}$ 'L' is in mm	Using Tape Scale Calibrator by Comparison Method IS - 1269 - 1997
22.	Bevel Protractors [§] L.C.: 5 Minutes	$\pm 90^\circ$	4.5 Minutes	Using Sine Bar by Comparison Method IS - 4239 - 1970 IS - 5812 - 1970
23.	Clinometers [§] L.C.: 1 Minute	$\pm 45^\circ$	53 s	Using Sine Bar & Gauge Block
24.	Electronic Levels [§] L.C.: 1 μ m/m	± 2 mm/mtr	4 μ m/m	Using Electronic Level & Tilting Table
25.	Spirit Levels [§] L.C.: 20 μ m/m	± 0.300 mm/mtr	12.0 μ m/m	Using Electronic Level & Tilting Table by Comparison Method IS - 5706 - 1993 & 1632 - 1993
26.	Surface Plates [§]	300 mm x 300 mm to 4000 mm x 4000 mm	$0.8 \sqrt{\frac{L+W}{120}}$ μ m L & W in mm	Using Electronic Level by Comparison Method IS - 7327 - 2003 (Granite) / IS - 2285 - 2003 (Cast Iron)
27.	Coating Thickness Gauges [§]	0 to 3 mm	3.0 μ m	Using PVC Foils

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28.	Sine Bars For Angle [§]	200 mm	9 arc sec	Using Slip Gauges, Dial Indicator, Surface Plate & Angle Gauge by Comparison Method IS – 5359 – 1987
29.	Three Point Micrometers [§]	8 mm to 90 mm 125 mm	4.9 μ m 7.0 μ m	Using Ring Gauges
30.	Test Sieves/s [§]	3 mm x 3 mm	10.9 μ m	Using Profile Projector by Comparison Method IS - 460 – 1985 (Part 3) & IS–1555–2004
		3 mm to 10 mm	16.0 μ m	Using Digimatic Caliper by Comparison Method IS - 460 – 1985 (Part 3) & IS–1555–2004
31.	Granite Squares [§]	600 mm x 450 mm	9.1 μ m	Using Granite Squares, Linear Height Gauge & Digimatic Dial Indicator by Comparison Method IS –6232 – 1971
32.	Straight Edge Parallelism Straightness [§]	1000 mm	4.4 μ m	Using Slip Gauge, Digimatic Gauge & Surface Plate by Comparison Method IS – 2220 – 1990 IS – 5268 – 1991 (Part-1)

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33.	Angle Plates ^s Flatness	300 mm x 300 mm	2.4 μ m	Using Slip Gauge Surface Plate Digimatic Gauge by Comparison Method IS – 2220 – 1990 IS – 5268 – 1991 (Part-1)
	Parallelism Squareness	300 mm x 300 mm	11.5 μ m	Using Dial Test Indicator Granite Square
34.	Tape / Scale Calibrators ^s L.C.: 0.001 mm	1000 mm	20.0 μ m	Using Length Bars
35.	Linear Height Gauges ^s (Linear Accuracy & Perpendicular) L.C.: 0.001 mm	0 to 600 mm	5.5 μ m	Using Length Bars & Surface Plate
36.	Bench Centre ^s (Parallelism & Coaxiality)	300 mm	8.8 μ m	Using Mandrel & Digimatic Gauge by Comparison Method IS – 5980 – 1978 IS – 2013 – 1995
37.	Pitch Gauge Set ^s	0.25 mm to 7 mm	6.3 μ m	Using Profile Projector
38.	Radius Gauge Set ^s	1 mm to 25 mm	9.0 μ m	Using Profile Projector
39.	Snap Gauge ^s	8 mm to 100 mm	3.0 μ m	Using Slip Gauge
40.	Try Square ^s	0 to 600 mm	6.5 μ m	Using Master Square Slip Gauge by Comparison Method IS – 2103 – 1980

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Sl.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (\pm)	Remarks
41.	Electronic Comparator ^s	0 to 25 mm	0.52 μ m/m	Using Slip Gauge
42.	Inside Micrometer ^s L.C.: 0.01 mm	50 mm to 63 mm	4.0 μ m	Using Slip Gauges, Length Bars & Electronic Comparator by Comparison Method IS – 2966 – 1964
		With Extension Rod 100 mm	4.0 μ m	
		With Extension Rod 200 mm	4.1 μ m	
		With Extension Rod 300 mm	4.2 μ m	
43.	Comparator Stand ^s Flatness	\varnothing 55 mm, 100 mm x 150 mm to 400 mm x 300 mm	4.0 μ m	Using Slip gauges, Try Square & Mandrel by Comparison Method IS – 7599-1975
	Perpendicularity	1000 mm	8.6 μ m	
44.	Thread Plug Gauge ^s	M 2 mm to M100 mm	1.71 μ m	Using Length Measuring Machine & Thread Wire Set by Comparison Method IS 2334 – 2001 & IS 1502 – 1996
45.	Thread Ring Gauge ^s	M 2 mm to M100 mm	1.09 μ m	Using Length Measuring Machine & Master Setting Ring by Comparison Method IS – 2334 – 2001
46.	Plain Ring Gauge ^s	\varnothing 2 mm to \varnothing 100 mm	1.09 μ m	Using Length Measuring Machine & Master Setting Ring by Comparison Method IS – 3485-1983
47.	Thread Wire Set ^s	0.17 mm to 6.35 mm	0.2 μ m	Using Length Measuring Machine by Comparison Method IS - 2334 - 2001

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48.	Mandrel [§] (Run Out, Variation in Diameter)	10 mm to 1000 mm	9.4 μ m	Using Millimess & Bench Centre by Comparison Method IS – 2063-2002 (Part-1) IS – 230 – 1996
49.	Linear Height Gauges* (Linear Accuracy & Perpendicular) L.C.: 0.001 mm	0 to 600 mm	5.5 μ m	Using Length Bars & Surface Plate
50.	Surface Plate*	600 mm x 600 mm to 4000 mm x 4000 mm	2.54 $\sqrt{L+W}$ /120 μ m L & W in mm	Using Electronic Level by Comparison Method IS 7327-2003 & IS 2285 – 2003
51.	Bench Center* (Parallellism & Coaxiality)	1000 mm	9.2 μ m	Using Mandrel & Millimess by Comparison Method IS – 5980 – 1978 IS – 2013 – 1995

* Measurement Capability is expressed as an uncertainty (\pm) at a confidence probability of 95%

[§]Only in Permanent Laboratory

*Only for Site Calibration

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